


<b>Search Notes</b>  	<b>Application/Control No.</b>  10538312	<b>Applicant(s)/Patent Under Reexamination</b>  NITSCHKE ET AL.
	<b>Examiner</b>  ICHIEH CHENG	<b>Art Unit</b>  4183

SEARCHED			
Class	Subclass	Date	Examiner
370	338, 328, 331	2/6/08	Ichieh Cheng
455	448	12/06/2008	M.F.

SEARCH NOTES		
Search Notes	Date	Examiner
Text searched attached	2/6/08	Ichieh Cheng
Updated search	12/06/2008	M.F.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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